

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/669,879	CHEN ET AL.
	Examiner	Art Unit
	Shick C. Hom	2666

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	235, 389,	5/13/2005	SH
370	390, 392,	5/13/2005	SH
370	412, 413,	5/13/2005	SH
370/414, 416, 417, 428, 429, 432		5/13/2005	SH